

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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In re application of: **Hideo HOSONO et al.**

Serial Number: **Not Yet Assigned**
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INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P. O. Box 1450
Alexandria, VA 22313-1450

September 27, 2004

Sir:


In compliance with 37 CFR 1.56, Applicants call to the attention of the Patent and Trademark Office the references listed on the attached PTO-1449 and international search report.

A copy of each of the references is enclosed herewith.

In the event there are any fees due in connection with the filing of this paper, please charge Deposit Account No. 50-2866.

Respectfully submitted,

WESTERMAN, HATTORI, DANIELS & ADRIAN, LLP



Sadao Kinashi

Reg. No. 48,075

Tele: (202) 822-1100

Fax: (202) 822-1111

SK/yap

Enclosures: PTO-1449; References (8) and international search report.

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INFORMATION DISCLOSURE STATEMENT PTO-1449	Atty. Docket No. 042631	Serial No. New Appln.
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U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)

FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Translation (Yes or No)
AA	2001-180962	07/03/01	Japan	Abstract. Cited in the PCT search report.
AB	09-241030	09/16/97	Japan	Abstract. Cited in the PCT search report.
AC	2001-72428	03/21/01	Japan	Abstract. Cited in the PCT search report.
AD	EP1084995	03/21/01	EPO	Yes. Cited in the PCT search report.
AE	2000-239040	09/05/00	Japan	Abstract. Cited in the PCT search report.
AF	EP0870737	07/24/02	EPO	Yes. Cited in the PCT search report.
AG	2001-311801	11/09/01	Japan	Abstract. Cited in the PCT search report.

OTHER DOCUMENTS

AH	Hideo Hosono; Oyo Butsuri, Vol. 69, No. 4, pp.415-419, April 10, 2000. Cited in the PCT search report.
Examiner	Date Considered